



SHEET 1 OF 1

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
**57454-982**SERIAL NO.  
**10/686,766**APPLICANT  
**Tadatoshi SUZUKI, et al.**FILING DATE  
**October 17, 2003**GROUP  
**3748****U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	

EXAMINER

*Jamie Corrigan*

DATE CONSIDERED

12-12-04

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<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>			ATTY. DOCKET NO. <b>57454-982</b>	SERIAL NO. <b>10/686766</b>			
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EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
		JIS G 0551 "Methods of austenite grain size determination for steel", Japanese Standard Association, February 20, 1998					
		JIS Z 2242 "Method of impact test for metallic materials", Japanese Standard Association December 21, 1998					
		JIS Z 2202 "Test pieces for impact test for metallic materials", Japanese Standard Association, February 20, 1998					
EXAMINER <i>Jamie Corrigan</i>			DATE CONSIDERED <i>12-12-04</i>				

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